

规格书编号

**SPEC NO:** 

# 产品规格书 SPECIFICATION

CUSTOMER 客 户:							
PRODUCT 产品:	SAW FILTER						
MODEL NO 型 号:	HDF100A W2						
PREPARED 编 制:	CHECKED 审 核	:					
APPROVED 批准:	DATE日期	: 2004-9-26					
客户确认 CUSTOMER RECEIVED:							
审核 CHECKED	批准 APPROVED	日期 DATE					

# 无锡市好达电子有限公司 Shoulder Electronics Limited



# 更改历史记录 History Record

更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark



# 1. SCOPE

**SAW FILTER** 

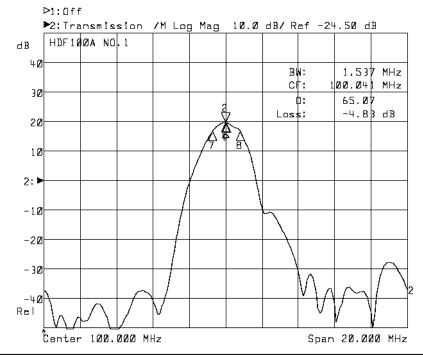
This specification shall cover the characteristics of SAW filter F100A

# 2. ELECTRICAL SPECIFICATION

DC Voltage VDC	10V	
AC Voltage Vpp	10V50Hz/60Hz	
Operation temperature	-40°C to +85°C	
Storage temperature	-45°C to +85°C	
RF Power Dissipation	0dBm	

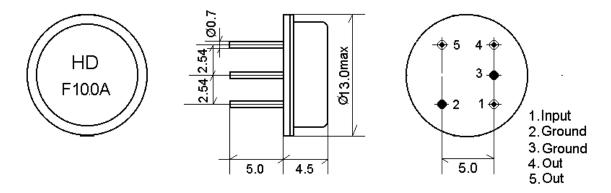
#### 2.2 Electronic Characteristics

型号	HDF100A	
Part Number		
中心频率(fo)(MHz)	100.0	
Nominal Center Frequency		
3dB 带宽	1.5 typ.	
Bandwidth(from fo)(MHz)		
30dB 带宽	4.5Mhzmax.	
Bandwidth(from fo)(MHz)		
插入损耗(dB)	6.0max	
Insertion Loss(at minimum loss point)		
群延时波动(fo+/-576KHz)(μ sce.)	0.200	
Group Delay Deviation	0.200	
输入/输出阻抗	50 Ω //0pF	
Input/output Impedance		





#### 3. DIMENSION



## 4. ENVIRONMENTAL CHARACTERISTICS

#### 4-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

#### 4-2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

#### 4-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2.2.

#### 4-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2.2.

#### 4-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2.2.

#### 4-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2.2.

#### 4-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2.2.





## 5. REMARK

**SAW FILTER** 

#### 5.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

## 5.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

#### 5.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.